



Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/815,398	YUEH ET AL.	
	Examiner	Art Unit	
	Sin J. Lee	1752	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
430		270.1		430	326	330	905	910	
INTERNATIONAL CLASSIFICATION				526	286				
G	03	C	1 / 73						
G	03	F	7 / 039						
G	03	F	7 / 20						
G	03	F	7 / 30						
C	08	F	28 / 02						

(Assistant Examiner) (Date)	 SIN LEE (Primary Examiner) (Date) 6/24/2006 PRIMARY EXAMINER	Total Claims Allowed: 18	
(Legal Instruments Examiner) (Date)		O.G. Print Claim(s) 1410	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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